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# Crystal structure and Electron Density of La<sub>0.64</sub>(Ti<sub>0.92</sub>Nb<sub>0.08</sub>)O<sub>3</sub> at 1000 °C and 1350 °C

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#### **Introduction**

Doped-La<sub>2/3</sub>TiO<sub>3</sub> materials have an *A*-site deficient perovskite-type structure (*ABO*<sub>3</sub>) where  $A=La_{2/3\pm y}$ ,  $B=(Ti_{1-x}M_x)$  and M is dopant cation. These materials are attractive owing to their high oxide-ion conductivities and dielectric properties. Therefore, many researchers have studied the unit-cell parameters, phase transition and structural parameters of the compounds. To improve their properties, it is important to understand the precise chemical bonding nature. But no study has yet been reported on the bonding nature of La<sub>0.64</sub>(Ti<sub>0.92</sub>Nb<sub>0.08</sub>)O<sub>3</sub>. Furthermore, no crystal structure data above 500 °C is available in the literature. Here, we have determined the crystal structure and electron density distribution by combining a Rietveld method, a maximum-entropy method (MEM) and whole pattern fitting using synchrotron X-ray diffraction intensity measured at 1000 °C and 1350 °C.

## **Experimental**

Synchrotron X-ray powder diffraction data were collected using the multi-detector system installed at the beam line BL-4B<sub>2</sub> of Photon Factory, KEK, Tsukuba. The wavelength was determined to be  $\lambda$ =1.20667(1) Å. A furnace with MoSi<sub>2</sub> heaters<sup>1</sup> was used for the high-temperature measurements. Diffraction data were collected at 1000 °C and 1350 °C in the 20 range from 7° to 154° in the step interval of 0.005° in 2 $\theta$ . Computer programs RIETAN-2000<sup>2</sup>, PRIMA<sup>3</sup> and VENUS<sup>3</sup> were utilized for Rietveld analysis, MEM calculation and visualization of the electron-density distribution, respectively.

#### **Results and discussion**

All the reflections in the synchrotron X-ray powder diffraction patterns measured at 1000 °C and 1350 °C were indexed on the basis of tetragonal symmetry with space group P4/mmm ( $a \approx a_p \times b \approx a_p \times c \approx 2a_p$ ). The calculated profiles fit well with that of observed one (Fig. 1). The final unit-cell and structural parameters and *R*factors for the two temperatures are summarized in Table I. The MEM analyses were performed using the structure factors obtained from the Rietveld analysis. The number of structure factors was 92 for both the data. The MEM



Fig.1 Rietveld fitting pattern measured at 1350 °C. Crosses (+ symbols) and line denote observed and calculated profile intensities, respectively. Short vertical bars represent Bragg reflection positions. A difference (observed-calculated) plot is shown bellow the profiles.



Fig.2 Equicontour surface of the electron-density distribution at 0.8 A<sup>3</sup> on the (001) plane of SR-XRD data of  $La_{0.64}(Ti_{0.92}Nb_{0.03})O_3$  measured at 1350 °C

calculations were done using PRIMA with the unit cell divided into  $64 \times 64 \times$ 128 pixels and wholepattern fitting using RIETAN-2000. Then, the MEM-based pattern fitting applied was which the reliability (value within improved factors within parentheses in Table 1). Electron-density image is shown in Fig.2 to visualize the density derived from the MEM calculations for the data measured at 1350 °C. The electron density map shows the covalent bonding between the O3 and TiNb atoms and between Ti,Nb and O2 atoms.

Table 1. Refined crystalparameters and reliabilityfactors of the $La_{0.64}(Ti_{0.92}Nb_{0.08})O_3$ 1000 (°C)1350 (°C)

Temperature			1000 (°C)	1350 (°C)
	Atom			
Refined parameters		a	3.90047(1)	3.91930(1)
		С	7.90938(3)	7.92535(2)
	La1	g(La1)	0.911(1)	0.883(1)
		$\widetilde{U}(\text{\AA}^2)$	0.0087(2)	0.0144(2)
	La2	g(La2)	0.369(1)	0.397(1)
		$U(\text{\AA}^2)$	0.0371(7)	0.0374(6)
	TiNb	Ζ	0.2663(2)	0.2655(1)
		$U(\text{\AA}^2)$	0.0123(3)	0.0160(3)
	01	$U_{\rm eg}({\rm \AA}^2)$	0.023	0.045
	O2	$U(Å^2)$	0.016(2)	0.031(2)
	O3	z(O3)	0.2496(4)	0.2552(4)
		$U_{eq}(\text{\AA}^2)$	0.035	0.041
Reliability factors	$R_{\rm wp}$ (%)		15.05(14.27)	13.43(11.69)
	$R_{\rm p}$ (%)		10.88(10.20)	10.03(8.70)
	$R_{\rm I}^{(\%)}$		8.93(6.25)	10.46(5.54)
	$R_{\rm F}$ (%)		9.6294.86)	5.79(3.52)
	S		2.18(2.06)	1.92(1.62)

Tetragonal space group *P4/mmm* (No.123) *Z*=2. In the analyses the atom positions were: La1 1*a* (0.0, 0.0, 0.0); La2 1*b* (0.0, 0.0, 1/2); TiAl 2*h* (1/2, 1/2, *z*); O1 1*c* (1/2, 1/2, 0.0); O2 1*d* (1/2, 1/2, 1/2); O3 4*i* (1/2, 0.0, *z*). Reliability factors shown in the parentheses are obtained after REMEDY cycles.

## <u>References</u>

- [1] M. Yashima et al, J. Appl. Cryst. 38, 854 (2005).
- [2] F. Izumi and T. Ikeda, *Mater. Sci. Forum* **321-324**, 198 (2000).
- [3] F. Izumi and R.A. Dilanian, "Recent Research Developments in Physics," Transworld Res. Network, Trivandrum (2002), p. 699.
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